

Notice of References Cited	Application/Control No. 10/801,718		Applicant(s)/Patent Under Reexamination HIRAIWA ET AL.	
	Examiner Daniel Kim		Art Unit 2185	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0010733	01-2005	Mimatsu et al.	711/162
*	B	US-2004/0039890	02-2004	Itoh et al.	711/162
*	C	US-2003/0200275	10-2003	Hirabayashi et al.	709/214
*	D	US-2004/0220975	11-2004	Carpentier et al.	707/200
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	J	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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